

**Fixed capacitors for use in electronic equipment –**

**Part 1: Generic specification**

**CORRIGENDUM 1**

**4.5.6 Conditions to be prescribed the relevant specification**

Replace in item b) 4.5.3 by 4.5.4.

**4.11.2 Inductance**

Replace the formula  $L_X = \frac{1}{4^2 \times f_r^2 \times C_X}$

by the formula  $L_X = \frac{1}{4\pi^2 \times f_r^2 \times C_X}$

**4.25.1.2 Test procedure**

Add, after the first paragraph, the following sentence:

The test specimens may be introduced into the chamber at any temperature from laboratory temperature to the upper category temperature.